Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	_
10/700,094	CHEN ET AL.	
Examiner	Art Unit	
Brian R. Peugh	2187	

SEARCHED			
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
711	4,154	7/7/2006	BRP	
360	78.08	7/7/2006	BRP	

SEARCH NO (INCLUDING SEARC)
	DATE	EXMR
Updated WEST search (text) IEEE search	7/6/2006	BRP
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